

# Detecting instant of multiple faults on the transmission line and its types using time–frequency analysis

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Shweta Na<sup>1</sup>, Nand Kishor<sup>1</sup> ✉, Kjetil Uhlen<sup>2</sup>, Soumya Ranjan Mohanty<sup>3</sup>

<sup>1</sup>Department of Electrical Engineering, Motilal Nehru National Institute of Technology Allahabad, India

<sup>2</sup>Department of Power Engineering, NTNU, Trondheim, Norway

<sup>3</sup>Department of Electrical Engineering, IIT BHU, Varanasi, India

✉ E-mail: nand\_research@yahoo.co.in

**Abstract:** In a complex interconnected network, due to dynamic interaction between the AC networks, during occurrences of faults, the successful relay operation is threatened. For security and reliability of the power system network, a fast and accurate protection scheme is of great importance. This study presents a protection scheme for multiple fault detection at bus/line and its type in a wide area network. If a fault occurs on a line, followed by another fault at the same/different line, before the clearance of former fault, the proposed scheme is capable of detecting such multiple fault events. The scheme applies processed signal information for its time–frequency representation using Smoothed Pseudo Wigner–Ville distribution, followed by Hilbert transform and calculation of indices to interpret the fault events. It is shown that faulted bus, faulted line, time instant, and types of faults can be easily identified with low computational burden. The scheme is validated on the signals simulated on Kundur's model, IEEE 39 bus system and verified with signals on real-time digital simulator for different fault conditions; fault resistance and fault location on the line. The scheme can be successfully applied on signals available from phasor measurement units for wide area network protection.

## 1 Introduction

Detection of the fault location in the transmission line is one of the vital concerns for power system security. Owing to the rapid growth in the technology to make the grid smarter, the use of synchrophasors for power systems has widened the geographical area. Synchrophasor technology offers a great future for dynamic supervision, protection, and control of wide-area power system. The phasor measurement unit (PMU) is a data acquisition system, realised through a digital recording device.

Different transient events such as faults, line switching, switching on/off of heavy loads, generator disconnection etc. do occur in the power system. Among these, quick and accurate detection of faults is important to avoid any cascading outages. To accelerate the repair and restoration of power supply, it is essential to know the complete information about the fault or if not known then must be estimated from the PMUs data with an acceptable accuracy [1–3].

In the last decade, several techniques have been reported on fault detection and classification using signal processing techniques, including artificial intelligence. The use of support vector machine and principal component analysis techniques, with different window sizes have been proposed in [4] for detection and classification of fault conditions. An improvement in classification accuracy, combined with wavelet transform was suggested in [5]. Wavelet transform has also been combined with different entropies [6]. The wavelet transform applied on three-phase current signals at sending end of line and using statistical decision-tree for classification was reported in [7]. Artificial neural networks, which have been widely studied for fault detection and classification, require a training process and need one cycle of information to classify events [8]. Fault identification was also addressed using fuzzy techniques [9, 10]. Such methods do not require a training process; however, their generalisation is more complex. The fault classification using moving sum of current signals was proposed in [11] and it was discussed that the moving sum remains non-zero during fault or transient conditions.

Most of the works based on PMUs data are concentrated on the identification of fault location [12–18]. The travelling wave-based

method has been proposed in [12], which was claimed to be immune to system parameters, but it requires very high sampling frequency and faces difficulty to discriminate between faulty and non-faulty measurements. The maximum wavelet singular value (MWSV) calculated through discrete wavelet transform (DWT) for a sliding window was discussed in [13]. Exceeding the value of MWSV above predefined threshold indicates the occurrence of fault. With a delay of 5 ms, the Euclidean norm of MWSV was computed and compared with the set value, based on which the faults are classified. Das *et al.* [14] suggested that the change in injected current at the faulted bus is non-zero while at non-faulted bus it is zero. A voltage magnitude (VM)-based approach has been discussed in [15] to identify the faulty bus. Furthermore, faulty line has been identified by comparing the angle of positive sequence current of all the connected lines to the faulty bus. A similar concept has been introduced in [16], except the use of sequence components of voltage and current phasors. Yu *et al.* [17] proposed the use of only voltage phasor to identify the fault. The scheme works in three folds; first to identify the fault region, second to identify faulted feeder, and lastly backup protection. Based on the level of voltage depression and recovery, identification of fault is analysed. Such economical approaches are fast and accurate.

The literature available has mainly discussed the study related to fault identification and classification limited to single fault occurrence at a time, but not to multiple events. In recent years, fault diagnosis has been investigated involving the consequences during fault scenarios, e.g. power swing that affects the relay operation. Such studies have been reported in [18] for uncompensated and compensated line [19]. Dubey *et al.* [20] used Koopman mode analysis for multiple faults diagnosis. The technique involving calculation of a threshold and rule base is reported in [21]; however, the calculation of threshold is tedious task and perhaps cannot be generalised. Gopakumar *et al.* [22] proposed the use of fast Fourier transform (FFT) coefficient from equivalent voltage/current phasor angle to detect the fault. It can reliably detect the fault but for simultaneous faults, it shows error and it takes  $1/f$  time period to detect the fault. Recently, Guillen *et al.* [23] proposed the power spectral density-based approach to detect and classify the faults on the transmission line. The current

signals are scaled using DWT in time and frequency domain at different decomposition levels. The obtained coefficients are used to form a wavelet covariance matrix. However, the decision about the fault and its classification remain predefined threshold value based.

In interconnected networks, on occurrence of an event, the propagation of dynamic transient due to dynamic interactions between the AC systems can be observed [24]. It is clear that with wide area measurements available from the bus, it is more important to achieve accurate and reliable detection of multiple faults that have occurred in the system in subsequent instant. Owing to the superimposition of signals available at the buses, it is more challenging to detect the faults, which occurs in one line following another line. In other words, the transient signal due to the fault event in one of the lines is more likely to propagate to another line and this situation becomes worse if another fault initiates before the former has cleared. This problem further aggregates if the fault is of different types in the subsequent instant of its occurrence. The failure in discrimination of such fault events is likely to lead maloperation of relays.

The main contribution of the proposed scheme lies in the fact that it is oriented to detect multiple faults occurrence within a time duration of 10 ms. It is capable of detecting those events that involve the occurrence of one fault, followed by another fault on the same line or nearby line. Fault detection is successful even for different fault conditions such as fault types; line to ground (LG), line to line to line (LLL), line to line (LL) occurrence on different lines, fault resistance and fault location. The noise in the range of 20 dB–50 dB signal-to-noise ratio (SNR) in the signals corresponding to inter-area modes (0–1 Hz) has been considered to detect coherency [25]. The reported scheme gives satisfactory results and has a high noise tolerance. Thus, it is important to validate any scheme that uses real-life PMU data measurements associated with noisy signals.

In this study, the proposed algorithm presents an approach to detect the multiple faults occurrence using advanced signal processed information. The voltage/current phasor of all the three phases available from the bus is processed into pseudo voltage phasor angle (PVPA), positive sequence components, and mean voltage deviation. Subsequently on PVPA signal, change in time–frequency spectra (CTFS) index is calculated using Smoothed Pseudo Wigner–Ville distribution (SPWVD) from time–frequency (TF) representation. This index is used to detect the bus near to the fault point and instant of its occurrence. Applying the Hilbert transform (HT) on the voltage deviation signal of each phase of the faulted bus results in complex form. The cluster formed from the scatter plot of absolute and imaginary components of complex value help in detecting the type of fault. Then, the total spectra coefficient (TSC) index is evaluated using SPWVD, for each connecting line from the faulted bus to identify the faulty line. The proposed scheme for multiple fault detection is first tested on a simple two-area system (Kundur's model) and further its validation is carried out on complex interconnected networks. The study is compared with the FFT method [22]. Furthermore, the efficacy of fault detection algorithm is tested using real-time measurement on a real-time digital simulator (RTDS). It is shown that subsequent fault occurrence (multiple faults before the clearance of former fault) can be easily detected using the signal from the bus associated with fault line. The detection remains accurate and reliable even if there exists superposition of the signal at the bus due to fault occurrence at one of the lines and another fault initiates (before the former fault has cleared) on adjoining line that connects to the same bus. The performance remains unaffected with the types of faults that occur in subsequent instants.

The paper is arranged as follows. The proposed methodology is briefly explained in Section 2, followed by the adoption of techniques in the algorithm explained in Section 3. The verification of the proposed methodology is discussed in Section 4. Finally, the conclusions are given in Section 5.

## 2 Proposed methodology

In this section, we discuss the techniques in detail, which are used in the proposed approach.

### 2.1 Signal transformation

**2.1.1 Pseudo voltage phasor angle (PVPA):** The fault occurrence results in maximum transient variation in voltage and current signals for the faulted bus/line. As such, these signals can be considered as a working signal for fault diagnosis. The three-phase voltage signals,  $V_R$ ,  $V_Y$ , and  $V_B$  from PMUs can be converted into two-phase orthogonal quantities;  $d$  and  $q$  components, i.e.  $V_d$  and  $V_q$  using Park's transformation. The PVPA is calculated as

$$\varphi_v = \tan^{-1}\left(\frac{V_q}{V_d}\right) \quad (1)$$

The PVPA ( $\varphi_v$ ) at all the buses is determined with respect to one of the generator bus which is considered as a reference bus. It is clear that this PVPA will remain constant for the healthy condition of the bus and on fault occurrence, a high-frequency component can be observed. As such, TF representation can be performed on the change in PVPA (CPVPA) signal, i.e.  $\Delta\varphi_v(t)$ , which indicates the energy content in the signal with respect to time and frequency. Obviously, the bus near to fault point has the highest energy content, which is denoted by change in time frequency spectra (CTFS) index.

**2.1.2 Positive sequence current:** Symmetrical components are used to simplify fault analysis by converting a three-phase unbalanced signal into symmetrical components. These sets of components are called the positive, negative, zero-sequence components and for current signal, it is calculated as

$$\begin{bmatrix} I_0 \\ I_1 \\ I_2 \end{bmatrix} = \frac{1}{3} \begin{bmatrix} I_R + I_Y + I_B \\ I_R + \alpha I_Y + \alpha^2 I_B \\ I_R + \alpha^2 I_Y + \alpha I_B \end{bmatrix} \quad (2)$$

where  $\alpha = e^{2\pi i/3}$ ,  $I_0$ ,  $I_1$ , and  $I_2$  are zero, positive, and negative sequence component, respectively. Mainly, the positive sequence current is of interest, which can accurately inform about the faulty line.

**2.1.3 Mean voltage deviation:** The three-phase mean voltage deviation ( $\Delta V_m$ ) at the  $k$ th bus with respect to the previous sliding window can be calculated from

$$\Delta V_{m,k} = \frac{|\Delta V_{R,k}| + |\Delta V_{Y,k}| + |\Delta V_{B,k}|}{3} \quad (3)$$

where  $\Delta V_{R,k}$  is the voltage deviation for the R phase

$$\Delta V_{R,k} = V_{R,k}((n+1)\text{th}) - V_{R,k}(n\text{th}), \quad n = \text{sample}$$

Whenever a fault occurs, the mean voltage deviation of the bus sharing the faulted line will show the highest absolute value. All three phases are involved in mean voltage, which will result in a higher threshold value (for any fault, transient appears in all phases). This is another analytics to confirm the presence of fault in the network.

### 2.2 Signal processing

**2.2.1 Smoothed pseudo Wigner–Ville distribution (SPWVD):** To characterise the power quality of a non-stationary signal, TF analysis has emerged as a powerful tool. There are two methods: linear and bilinear. The former method has less computational complexity but at the cost of TF resolution. The disadvantage associated with bilinear methods is typical interface called cross-terms. SPWVD is a bilinear method featured by a

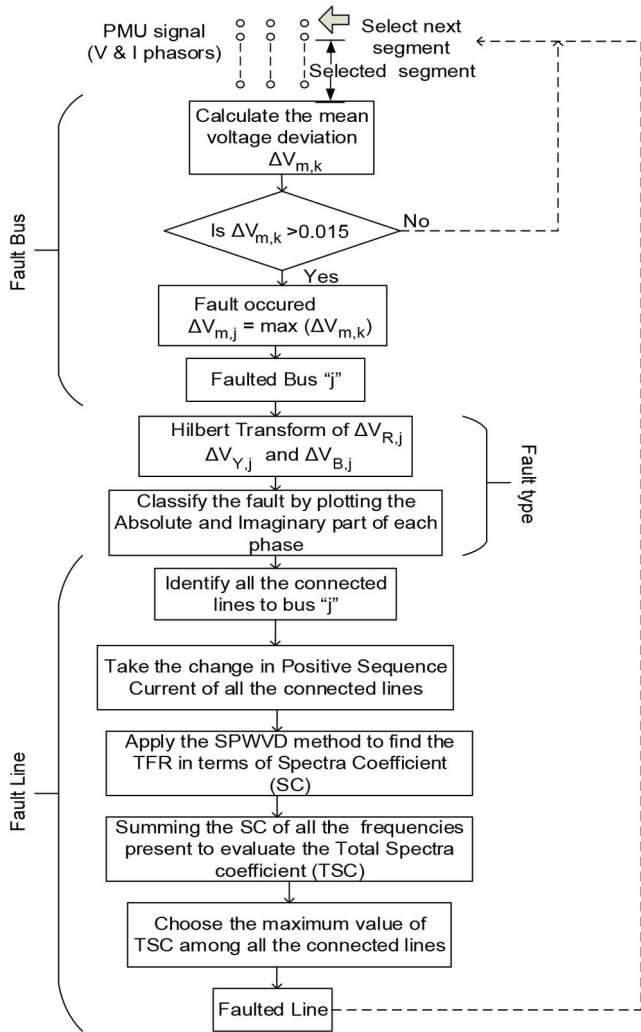


Fig. 1 Flow chart of the algorithm

separable kernel, which allows smoothing to be adjusted independently for both time and frequency, hence becomes one of the most flexible Cohen's class TF distributions. The TF representation of non-stationary signal of CPVPA, i.e.  $\Delta\varphi_v(t)$  using Wigner–Ville spectrum (WVS) is given as [26]

$$\mathfrak{E}_{\Delta\varphi_v\Delta\varphi_v}(t, f) = \mathfrak{F}_{\tau \rightarrow f} \left\{ \mathfrak{E} \left[ \Delta\varphi_v \left( t + \frac{\tau}{2} \right) \Delta\varphi_v^* \left( t - \frac{\tau}{2} \right) \right] \right\} \quad (4)$$

where  $\mathfrak{E}[\cdot]$  stands for expectation operator and  $\mathfrak{F}\{\cdot\}$  stands for Fourier transform.

Under certain conditions, the WVS is ensemble average of the Wigner–Ville distribution,  $\dot{W}_{\Delta\varphi_v\Delta\varphi_v}(t, f)$  of the realisations of the signal [21]

$$\mathfrak{E}_{\Delta\varphi_v\Delta\varphi_v}(t, f) = \mathfrak{E} \left[ \dot{W}_{\Delta\varphi_v\Delta\varphi_v}(t, f) \right] \quad (5)$$

$$\dot{W}_{\Delta\varphi_v\Delta\varphi_v}(t, f) = \mathfrak{F}_{\tau \rightarrow f} \left[ \Delta\varphi_v \left( t + \frac{\tau}{2} \right) \Delta\varphi_v^* \left( t - \frac{\tau}{2} \right) \right] \quad (6)$$

$\mathfrak{E}_{\Delta\varphi_v\Delta\varphi_v}(t, f)$  can be estimated via local averaging

$$\mathfrak{E}_{\Delta\varphi_v\Delta\varphi_v}(t, f; \theta) = \dot{W}_{\Delta\varphi_v\Delta\varphi_v}(t, f) \otimes \theta(t, f) \quad (7)$$

where  $\otimes$  is the convolution on  $t$  and  $f$ , and  $\theta(t, f)$  is a smoothing function.

The SPWVD [27] for processed CPVPA signal is given as

$$\begin{aligned} \mathfrak{E}_{\Delta\varphi_v\Delta\varphi_v}^W(t, f) &= \dot{W}_{\Delta\varphi_v\Delta\varphi_v}(t, f) \otimes \theta(t, f) \\ \mathfrak{E}_{\Delta\varphi_v\Delta\varphi_v}^W(t, f) &= \mathfrak{F}_{(v,\tau) \rightarrow (t,f)} \left\{ \mathcal{A}_{\Delta\varphi_v\Delta\varphi_v}(v, \tau) \vartheta(v, \tau) \right\} \\ \mathcal{A}_{\Delta\varphi_v\Delta\varphi_v}(v, \tau) &= \mathfrak{F}_{t \rightarrow v} \left\{ \Delta\varphi_v \left( t + \frac{\tau}{2} \right) \Delta\varphi_v^* \left( t - \frac{\tau}{2} \right) \right\} \\ \vartheta(v, \tau) &= \mathfrak{F}_{(t,f) \rightarrow (v,\tau)}^{-1} \left\{ \theta(t, f) \right\} \end{aligned} \quad (8)$$

where  $\mathfrak{F}_{(v,\tau) \rightarrow (t,f)}$  is the Fourier transform, passing the ambiguity function domain to the TF domain and  $\mathcal{A}_{\Delta\varphi_v\Delta\varphi_v}(v, \tau)$  is the ambiguity function of  $\Delta\varphi_v(t)$ .

A simple version of the multiform-tilt-able exponential kernel [28] is used to suppress the interference terms

$$\vartheta(v, \tau) = \exp \left\{ -\pi \left[ \left( \frac{v}{v_0} \right)^2 + \left( \frac{\tau}{\tau_0} \right)^2 \right]^{2\lambda} \right\} \quad (9)$$

The TF spectra coefficient and change in time frequency spectra (CTFS) are calculated using (8). The information contained in the TF spectra signifies the energy content of a particular frequency at that instant. Hence, the bus which shares the faulted line is expected to indicate higher energy content.

Similarly, the deviation in positive sequence line current ( $\Delta I(t)$ ) can be considered as a working signal and so, the TF spectra become  $\mathfrak{E}_{\Delta I \Delta I}(t, f)$ . The TSC is determined as

$$\text{TSC} = \sum_{f=0}^{f_s/2} \mathfrak{E}_{\Delta I \Delta I}(t, f) \quad (10)$$

where  $f_s$  is the sampling frequency.

A higher TSC value among the lines indicates a faulty line.

**2.2.2 Hilbert transform (HT):** The HT defined on the real signal  $\Delta V_{i,k}(t)$ , where  $i = R, Y$  and  $B$  phase is extended into the complex plane such that it satisfies the Cauchy–Riemann equations. It extracts instantaneous information of amplitude and phase. It refers to the following equations:

$$H(\Delta V_{i,k}(t))(t) = \frac{1}{\pi} P \int_{-\infty}^{\infty} \frac{\Delta V_{i,k}(t)}{t - \tau} d\tau \quad (11)$$

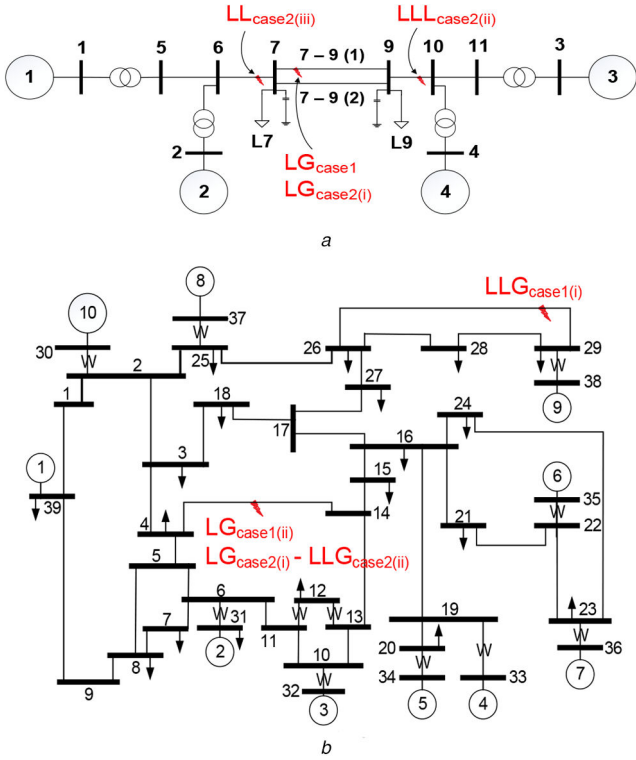
$$\Delta V_{i,ka}(t) = \Delta V_{i,k}(t) + j \cdot H(\Delta V_{i,k}(t))(t) \quad (12)$$

Now, evaluate the absolute and imaginary component from (12) for the voltage deviation signal of all three phases. The scatter plot of these features (components) will form clusters for fault signals involving a particular phase. The types of faults will affect the pattern representation of clusters, i.e. faulty phase features will be located away from the origin in absolute and imaginary plane as discussed in Section 4. This helps in identifying the fault types.

### 3 Algorithm

This section presents the discussion on the application of the above discussed techniques for fault diagnosis in the power system. The objective of diagnosis lies in three folds; (i) detect the faulted bus, (ii) its type, and (iii) identify the faulted line. The proposed method in the form of flow chart is presented in Fig. 1.

The signals, three-phase voltage and current are sampled from PMU on a base frequency of 50 Hz, have a sampling rate of 1 kHz. This results in 1000 samples in 1 s (i.e. 50 cycles) and the algorithm runs on a sliding window of 100 samples, with 90% overlap. It means that during each iteration of the proposed algorithm, ten new samples are included in analysis window. The computational time taken by the algorithm to take decision about the characteristic of fault and its location is 9.54 ms, so the fault occurrence is detected within 10 ms. In the first step, mean voltage deviation  $\Delta V_{m,k}$  is calculated for all the buses, wherein  $k$  denotes the buses. A threshold value of 0.015 is determined by considering the condition of least severe fault that could be possible in the



**Fig. 2 Test systems**  
 (a) Two-area Kundur's model,  
 (b) IEEE 39 bus system

network. The bus connecting the line with fault occurrence is now determined from

$$\text{Fault bus } j, \quad \Delta V_{m,j} = \max(\Delta V_{m,k}) \quad (13)$$

The three-phase voltage signals from the corresponding bus are used to determine the type of fault. The HT is applied to the mean voltage deviation signal of each phase and their absolute and imaginary components are plotted.

Furthermore, the TF representation using SPWVD is analysed on positive sequence line current signals. The maximum value of TSC calculated for all the lines that connect the fault bus suggests the fault line.

## 4 Verification of the proposed approach

The above described methodology for fault diagnosis is performed on the IEEE standard power system network models simulated on MATLAB/Simulink R2013a platform.

### 4.1 Test system

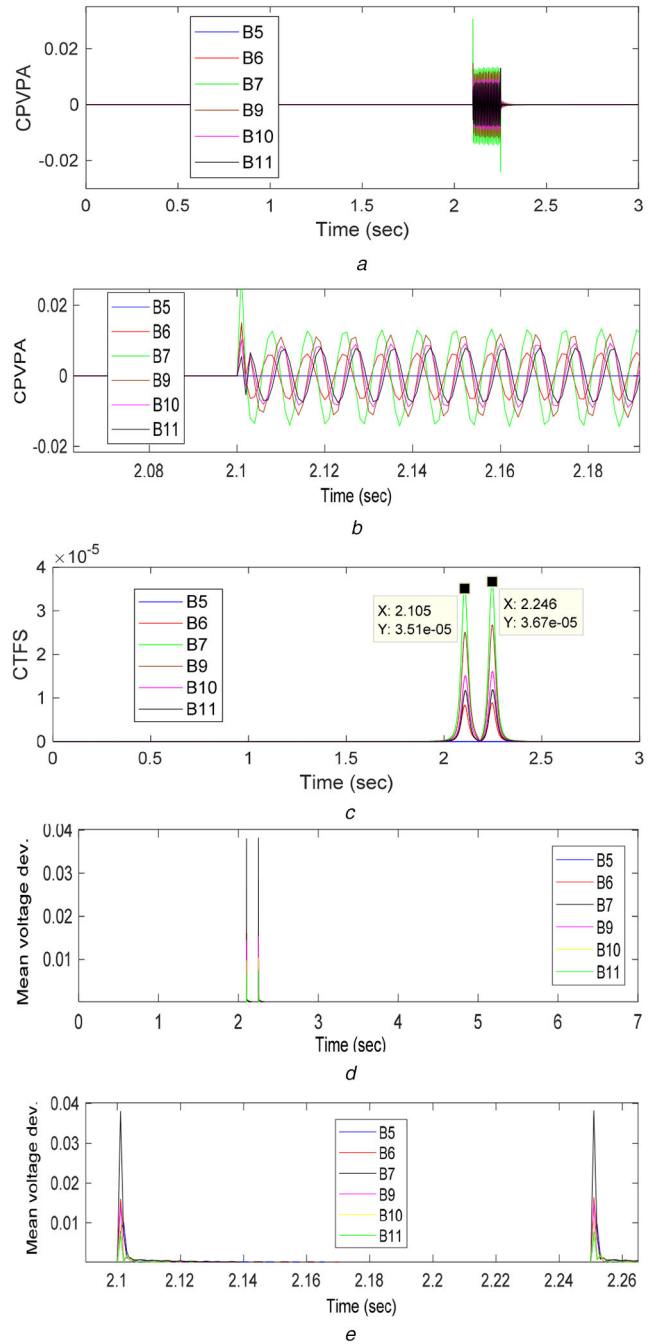
Fig. 2a depicts the single line diagram of two-area Kundur's model that consists of four machines (G1 and G2 belong to area 1 & G3 and G4 to area 2) and under normal operating conditions, power flows from area 1 to area 2.

The detailed models of machines including the control parameters are simulated [29]. PMUs are assumed to be installed on buses 5–11. The well-known IEEE 39 bus test system [30] is also considered that consists of 39 buses with ten generators.

Fig. 2b shows the single line diagram of the said bus system. The details on the description of multiple faults simulated in study and as shown in Fig. 2 are discussed in the next section.

### 4.2 Two-area Kundur's model

First, in the study, the performance of the proposed approach is investigated on a simple two-area network. The different case studies are performed for fault created on the lines that connect the two areas.



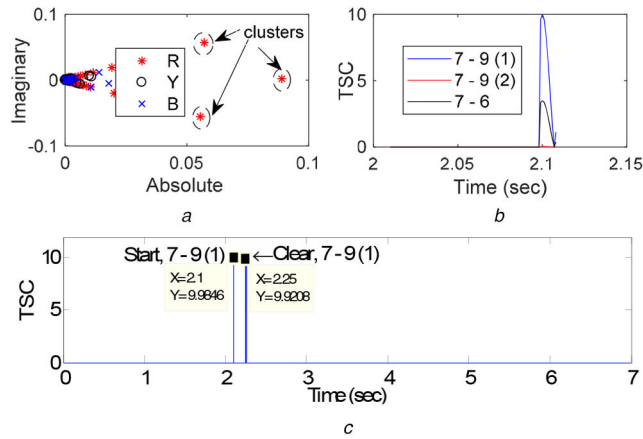
**Fig. 3 Fault bus identification**

- (a) CPVPA at all buses,
- (b) Zoomed plot of CPVPA variation,
- (c) CTFS at buses,
- (d) Mean voltage deviation,
- (e) Zoomed plot of mean voltage deviation

*Case 1: Single instant of fault occurrence (LG<sub>case1</sub>)* – A LG fault with a fault resistance ( $R_f$ ) of 100  $\Omega$  is created on the transmission line (1) that connects the buses 7–9, i.e. 7–9(1), at 23% distance from bus 7. The fault occurs at  $t = 2.1$  s and allowed to get cleared at  $t = 2.25$  s.

The variation in CPVPA at all buses during the fault duration in the analysis window can be seen in Figs. 3a and b. The maximum value of CTFS is indicated for bus 7 as observed in Fig. 3c. This suggests bus 7 shares the line with fault occurrence. It is also confirmed from the variation of mean voltage deviation as observed in Figs. 3d and e. Now, the fault type and fault line are investigated and shown in Fig. 4. The scattered absolute and imaginary components obtained from HT corresponding to R-phase in Fig. 4a suggest the LG fault type. The phase that involves fault has its distribution of features (HT) in the form of clusters





**Fig. 4** Detection of fault type and its duration for case 1 in the two-area system

- (a) LG(R-G) fault near bus 7,
- (b) TSC of connecting lines,
- (c) Fault at line 7–9 (1) and its timing

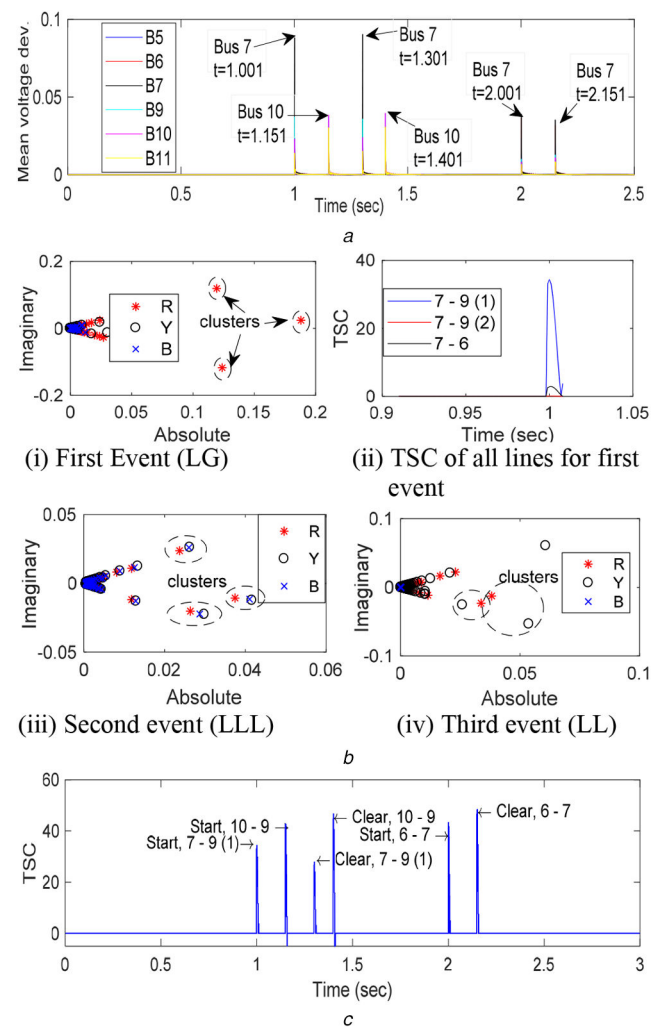
**Table 1** TSC for all the connected lines in two-area Kundur's model

| Fault details  | Fault bus | Connected lines | TSC           |
|--|-----------|-----------------|---------------|
| (i) no fault   | —         | —               | 0             |
| ii) LL fault in 7–9 (1), 10% distance from bus 7, $R_f = 100 \Omega$     | 7         | <b>7–9 (1)</b>  | <b>63.89</b>  |
|  |           | 7–9 (2)         | 35.08         |
|  |           | 7–6             | 0.3494        |
| iii) LLL fault in 7–9 (2), 50% distance from bus 7, $R_f = 0.001 \Omega$ | 9         | <b>7–9 (1)</b>  | <b>0.9358</b> |
|  |           | <b>7–9 (2)</b>  | <b>444.2</b>  |
| iv) LLG fault in 6–7, 90% distance from bus 6, $R_f = 200 \Omega$        | 6         | <b>6–7</b>      | <b>15.24</b>  |
|  |           | 5–6             | 3.539         |
| v) LG fault in 9–10, 10% distance from bus 9, $R_f = 50 \Omega$          | 9         | 7–9 (1)         | 0.2432        |
|  |           | 7–9 (2)         | 0.2433        |
|  |           | <b>9–10</b>     | <b>36.4</b>   |

located away from the origin of the plot. The fault associated with bus 7 connects multiple circuits with bus 9 and a line with bus 6, but the TSC calculated for signals further confirms the fault occurrence on lines 7–9(1). The fault duration with information on fault initiation and its clearance can be observed in Fig. 4c, shown as sliding window (100 samples) with 90% overlapping of the previous window for complete duration of the signal. The performance of the proposed method is further validated for different conditions and given in Table 1. The no fault condition indicates zero value of TSC. As from the flow chart, it is clear that the mean voltage deviation is  $<0.015$  for each iteration and hence the TSC index remains zero, indicating no fault case. It is understood that the value of TSC satisfactorily indicates the fault occurrence in the line.

**Case 2: Multiple instants of fault occurrence** – This case is investigated for the simultaneous occurrence of faults of different types in the network. In other words, the network (line) experiences one type of fault and meanwhile another type of fault is initiated before the first fault has cleared. The following multiple fault events (Fig. 2a) are created to test the proposed approach:

- (i) First event:  $LG_{case2(i)}$ (R-G) fault with a fault resistance  $0.01 \Omega$  on line 7–9(1) at 23% distance from bus 7, occurs at  $t = 1$  s and cleared at  $t = 1.3$  s.
- (ii) Second event:  $LLL_{case2(ii)}$  fault with a fault resistance  $200 \Omega$  on line 10–9, at 10% distance from bus 10, occurs at  $t = 1.15$  s and clears at  $t = 1.4$  s.
- (iii) Third event:  $LL_{case2(iii)}$  (R–Y) fault with a fault resistance  $100 \Omega$  on line 6–7, at 90% distance from bus 6, occurs at  $t = 2.0$  s and clears at  $t = 2.15$  s.



**Fig. 5** Detection of multiple faults

- (a) Fault bus identification,
- (b) Fault types detection: (i) first event (LG), (ii) TSC of all lines for the first event, (iii) second event (LLL), (iv) third event (LL),
- (c) Multiple faults sequence on different lines

From Fig. 5a, the fault associated bus is clearly evident. The absolute and imaginary components calculated for a signal from bus 7 suggest the scatter corresponding to R-phase only, i.e. LG fault. This is evident from Fig. 5b(i). The phase (R) involving fault has separated out from the features of healthy (Y & B), mainly concentrated near origin axis. Furthermore, as an example in Fig. 5b(ii), the TSC plot for the first event also suggests the fault

**Table 2** Faulted bus and Faulty line detection for a single event on two-area Kundur's model using FFT coefficient [22]

| Fault details  | Bus      | $\alpha_{100}$ | Faulty bus | Connected buses | $\beta_{100}$   | Detection |
|--|----------|----------------|------------|-----------------|-----------------|-----------|
| (i) LG fault in 7–9 (1), 23% distance from bus 7, $R_f = 100 \Omega$     | 5        | 0              | 7          | <b>7–9</b>      | <b>0.4468</b>   | ✓         |
|  | 6        | 0.5845         |            | 7–6             | 0.61995         |           |
|  | <b>7</b> | <b>1.204</b>   |            |                 |                 |           |
|  | 9        | 0.7579         |            |                 |                 |           |
|  | 10       | 0.7579         |            |                 |                 |           |
|  | 11       | 0.4517         |            |                 |                 |           |
| ii) LLG fault in 6–7, 90% distance from bus 6, $R_f = 200 \Omega$        | 5        | 0              | 7          | 7–9             | 0.16274         | ✓         |
|  | 6        | 0.7540         |            | <b>7–6</b>      | <b>0.076882</b> |           |
|  | <b>7</b> | <b>1.5229</b>  |            |                 |                 |           |
|  | 9        | 0.1045         |            |                 |                 |           |
|  | 10       | 0.3219         |            |                 |                 |           |
|  | 11       | 0.5303         |            |                 |                 |           |
| iii) LLL fault in 7–9 (2), 50% distance from bus 7, $R_f = 0.001 \Omega$ | 5        | 0              | 7          | <b>7–9</b>      | <b>0.18418</b>  | ✓         |
|  | 6        | 2.8017         |            | 7–6             | 0.48797         |           |
|  | <b>7</b> | <b>4.6436</b>  |            |                 |                 |           |
|  | 9        | 0.2360         |            |                 |                 |           |
|  | 10       | 1.1752         |            |                 |                 |           |
|  | 11       | 0.001          |            |                 |                 |           |
| (v) LG fault in 9–10, 10% distance from bus 9, $R_f = 50 \Omega$         | 5        | 0              | 9          | <b>9–10</b>     | <b>0.17315</b>  | ✓         |
|  | 6        | 0.1397         |            | 9–7             | 0.39824         |           |
|  | 7        | 0.3441         |            |                 |                 |           |
|  | <b>9</b> | <b>4.3265</b>  |            |                 |                 |           |
|  | 10       | 2.5950         |            |                 |                 |           |
|  | 11       | 0.6501         |            |                 |                 |           |

| Event 1  |                |            |                 |               | Event 2 |                |            |                 |               | Event 3 |                |            |                 |               |
|----------|----------------|------------|-----------------|---------------|---------|----------------|------------|-----------------|---------------|---------|----------------|------------|-----------------|---------------|
| Bus      | $\alpha_{100}$ | Faulty Bus | Connected Buses | $\beta_{100}$ | Bus     | $\alpha_{100}$ | Faulty Bus | Connected Buses | $\beta_{100}$ | Bus     | $\alpha_{100}$ | Faulty Bus | Connected Buses | $\beta_{100}$ |
| 5        | 0              |            |                 |               | 5       | 0              |            |                 |               | 5       | 0              |            |                 |               |
| 6        | 0.676          |            | <b>9 - 7</b>    | <b>0.2376</b> | 6       | 0.225          |            | 7 - 9           | 0.5212        | 6       | 0.102          |            | 7 - 9           | 0.204         |
| 7        | 1.562          |            | Right detection |               | 7       | <b>0.452</b>   | 7          | Wrong detection |               | 7       | <b>0.204</b>   | 7          | Right detection |               |
| <b>9</b> | <b>1.586</b>   | 9          |                 |               | 9       | 0.069          |            | <b>7 - 6</b>    | <b>0.2262</b> | 9       | 0.002          |            | <b>7 - 6</b>    | <b>0.101</b>  |
| 10       | 1.159          |            | 9 - 10          | 4.269         | 10      | 0.101          |            |                 |               | 10      | 0.035          |            |                 |               |
| 11       | 0.865          |            |                 |               | 11      | 0.169          |            |                 |               | 11      | 0.068          |            |                 |               |

**Fig. 6** Case 2: multiple faults detection on two- area Kundur model using FFT coefficient [22]

occurrence on lines 7–9(1). The fault type for second and third events as illustrated in Figs. 5b(iii) and (iv) indicate LLL and LL faults, respectively. The scatter of HT for all three phases are together in a cluster for LLL type fault, while for LL type, the phases involved in fault are scattered apart from the healthy phase.

With LL fault (R, Y phases), overlapping between clusters involving R, Y phases are clearly visible, while the B phase, which is healthy, is concentrated at origin. In other words, with LL type fault, the HT is seen to have wide spread scatter for the phase undergoing fault. The scatter of absolute and imaginary components corresponding to all three phases remains in the same cluster with respect to each other for LLL fault in contrast to LL fault wherein, due to unsymmetrical cluster between faulty phases is not formed. The detection of multiple faults is successfully shown in Fig. 5c. It is clear that simultaneous faults of different types can be accurately detected, including their instant of occurrence and clearance. The proposed methodology applied on sliding window indicates the instant of the first event on lines 7–9(1) and also reliably suggests the second event on line 10–9, before the former fault has cleared. It is to mention here the value of TSC for each fault event depends on several factors; its severeness, fault location, fault type, and fault resistance.

The comparative analysis for above conditions on two-area Kundur's model using FFT coefficient [22], evaluated on the equivalent voltage phasor angle (EVPA) signal is given in Table 2. It can be seen for single fault event, the detection is achieved successfully using the said method. Fig. 6 presents comparative analysis for multiple fault events. It is clear that the FFT method shows wrong detection of event 2, means erroneous decision about

the fault location. The other limitation is that the FFT method does not differentiate between the lines (for double circuit line), as it treats both as single line. It detects the fault with respect to the iteration window, but not the exact instant of fault.

*Performance with noise content* – To validate the efficacy of the proposed algorithm, the signal with noise content of 30 and 20 dB SNR for case 1 and case 2, respectively, are analysed further. The mean voltage shown in Fig. 7a accurately indicates the instant of fault event and its clearance. The scatter plot (HT) and TSC of LG fault near bus 7 can be clearly observed in Figs. 7b and c, respectively. The changes in TSC value confirm the duration of event. Next, the analysis for multiple events (case 2) with noise content of 20 dB is illustrated in Fig. 8. The mean voltage deviation infers accurately the instant of multiple faults and their duration as shown in Fig. 8b.

The distinct representation of different fault types can be observed in Fig. 8c and TSC values in Fig. 8d further confirms the duration of multiple faults.

### 4.3 IEEE 39 bus system

This model consists of several buses interconnected to each other in a wide spread geographical area. The following cases have been considered for analysis.

*Case 1: Multiple instants of fault occurrence* – The following types of events are considered:

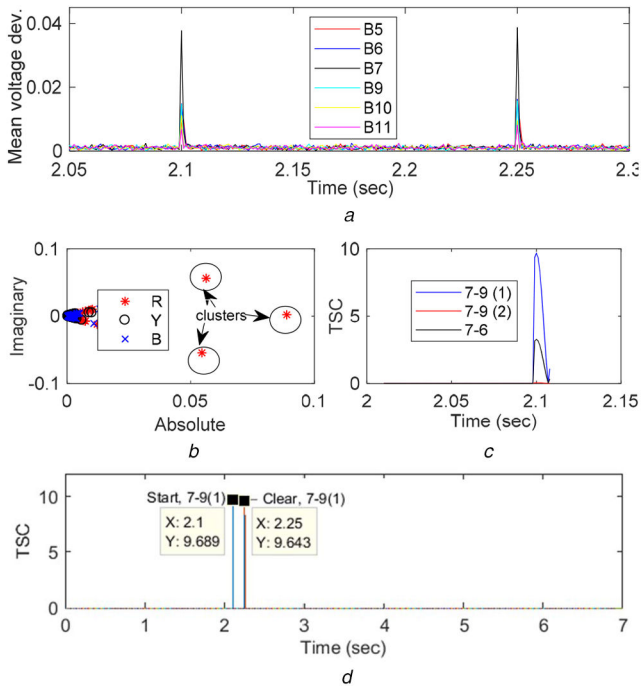
- (i) First event:  $LLG_{\text{case 1(i)}}$  fault with a fault resistance  $100 \Omega$  on line 29–26, at 10% distance from bus 29, occurs at  $t=1$  s and clears at  $t=1.27$  s.
- (ii) Second event:  $LG_{\text{case 1(ii)}}$  fault with a fault resistance  $10 \Omega$  on line 4–14 at 50% distance from bus 4, occurs at  $t=1.15$  s and clears at  $t=1.35$  s.

In Fig. 9a, the mean voltage deviation shows the correct sequence of fault occurrence on buses 29 and 14. This suggests that these buses share the lines associated with faults. In the single line diagram (Fig. 2b), bus 29 is connected to buses 26 and 28. In Fig. 9b(i), the HT suggests line–line–ground (LLG) fault type and TSC calculated for signals from the lines that connect these buses indicates fault occurrence on line 29–26. The close observation indicates that HT scatters for phases undergoing faults lie close to each other and thus in the same cluster unlike as determined for LL type (see Fig. 5b(iv)). Next, the second event as illustrated in Fig. 9b(ii) is indicated as LG fault type on line 4–14. A distinct cluster formation is achieved for LG or LLG for faulty phases. The performance of the proposed algorithm on correctly detecting the instant of fault initiation and its clearance for fault lines can be seen in Fig. 9c. As expected, due to the initiation of multiple faults (of different types) at  $t=1$  s and  $t=1.15$  s leading to the superposition of signals, does not actually affect the detection performance.

*Case 2: Multiple instants of fault occurrence on same bus* – In this case, study, a given fault type is allowed to get converted into another type on the same line. Following is the description of fault occurrence.

- (i) First event:  $LG_{\text{case 2(i)}}$  (R-G) fault with a fault resistance  $10 \Omega$  on line 4–14, at 50% distance from bus 4, occurs at  $t=1$  s and at  $t=1.15$  s,
- (ii) Second event: The above event gets converted into  $LLG_{\text{case 2(ii)}}$  (RY-G) type and finally clears at  $t=1.35$  s. The sequence of events is indicated as  $LG_{\text{case 2(i)}}-LLG_{\text{case 2(ii)}}$  (Fig. 2b).

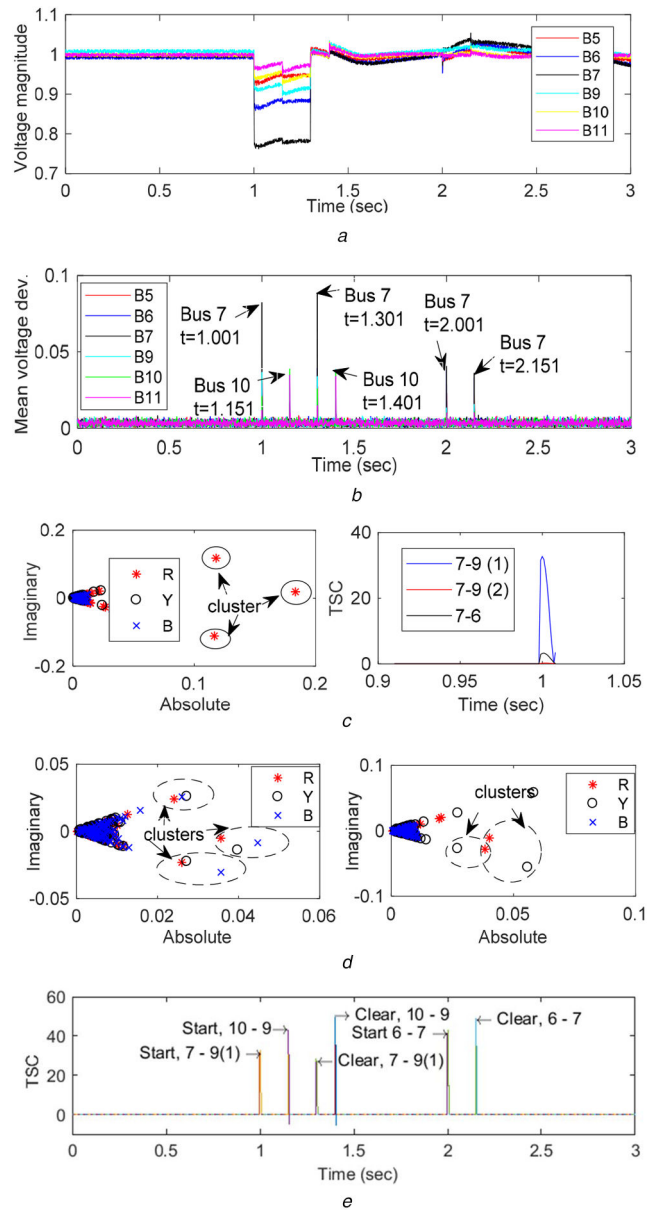
Fig. 10a shows the identification of fault bus 14, with information on its occurrence. The instant at which LG fault gets converted into LLG fault at the same location is also accurately detected. Next, the scatter of HT as shown in Fig. 10b depicts the faults as LG and



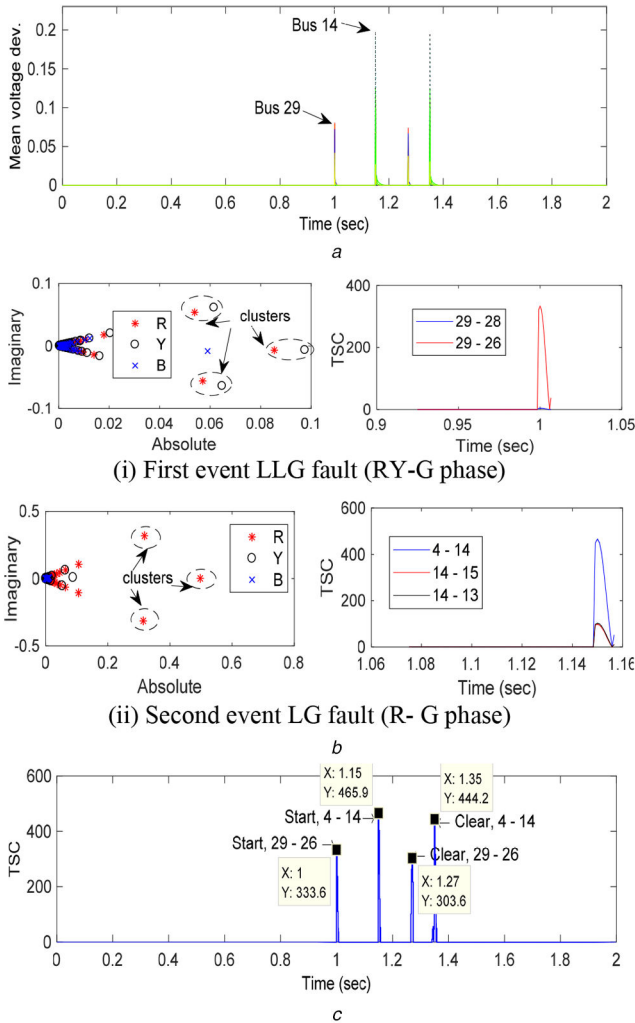
**Fig. 7** Detection of fault type and its duration for case 1 with 30 dB SNR  
 (a) Mean voltage deviation,  
 (b)  $LG_{\text{case 1(i)}}$  fault near bus 7,  
 (c) TSC of connecting lines,  
 (d) Fault at line 7–9 (1) and its timing

LLG with the involvement of R-phase and RY-phase, respectively. The detection of LLG and LG faults with distinct cluster formation for faulty phases remains consistent as discussed above. The analysis window for the signal from bus 14 with an update of ten new samples leads to the conclusion that the first event (LG type) has converted into another type (LLG). The instant of their occurrence can be observed in Fig. 10c. Furthermore, to demonstrate the performance for different fault cases, Table 3 gives the computed TSC. It is clear that the line undergoing fault results to have a maximum value of TSC (given in bold) and this remains consistent irrespective of fault types, its location on the line and fault resistance.

Next in the study, the proposed scheme is validated in real-time environment on RTDS for IEEE 39 bus system. The real-time simulation cases; case 1 and case 2 as discussed above are performed and the performance of the proposed scheme is given in Table 4. The detection of faulty buses (29, 14) and lines (29–26, 14–4) for case 1 follows the same trend (Fig. 11). Similarly, in case 2, faulty bus (14) and line (14–4) are detected and this is consistent with above discussion (Fig. 10). In Fig. 11a, it is observed that the



**Fig. 8** Detection of multiple faults with 20 dB SNR  
 (a) Voltage magnitude of R-phase,  
 (b) Fault bus identification,  
 (c) Fault types detection: (i) first event (LG), (ii) TSC of all lines for first event, (iii) second event (LLG), (iv) third event (LL),  
 (d) Multiple faults sequence on different lines



**Fig. 9** Detection of multiple faults and their duration in IEEE39 bus system

- (a) Fault bus identification,  
 (b) Fault types detection: (i) first event LLG fault (RY-G phase), (ii) second event LG fault (R- G phase),  
 (c) Multiple faults sequence on different lines

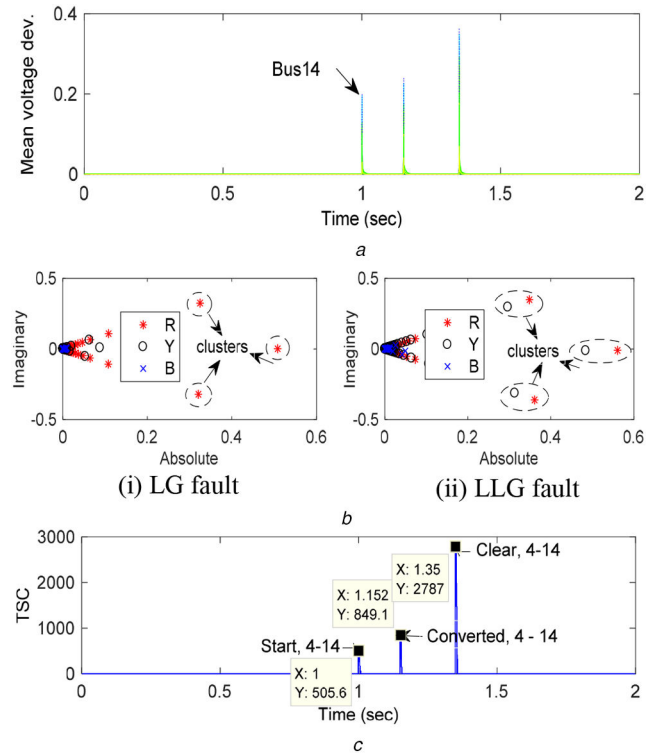
HT features of LLG fault (R,Y phase) can be considered in the same cluster, while with LG fault (R-phase), its corresponding faulty phase separates out from the origin.

The peak of TSC shown in Fig. 11b indicates the instant of multiple faults occurrence. Next, in Figs. 11c and d, consistent results are indicated in view of the identification of fault types and their sequence.

The performance of the proposed algorithm satisfactorily concludes its application in real-time. It is obvious that real-time measurement includes most dynamics of system and thus transient signals. As a result, for the same fault duration and sequence, a number of HT features are separated out and lie within the same cluster unlike simulated results having only one feature in each cluster (Figs. 5, 7–10).

## 5 Conclusion

The study presented a computationally reliable method for detection of instant of multiple faults and their types. The algorithm was applied on 100 samples window with 90% overlap for complete length of signal, suggesting a frame of only ten new samples in analysis for detection of fault instant and its type. In the first step, the signals available via PMUs were processed and subsequently TF representation was obtained using SPWVD technique. The calculation of indices from TF representation successfully interpreted the fault events. The calculation of change in TF spectra and TSC was capable of accurately indicating the



**Fig. 10** Detection of multiple fault types on the same bus and its duration  
 (a) Fault bus identification,  
 (b) Fault types detection: (i) LG fault, (ii) LLG fault,  
 (c) Multiple faults sequence on line 4–14

**Table 3** TSC for all the connected lines in IEEE 39 bus system

| Fault details   | Fault bus | Connected Lines | TSC           |
|---|-----------|-----------------|---------------|
| (i) LLG fault in 26–29, 10% distance from bus 26, $R_f = 1 \Omega$  | 26        | 26–25           | 517.6         |
|   |           | 26–27           | 516.7         |
|   |           | 26–28           | 195.5         |
|   |           | <b>26–29</b>    | <b>3767.8</b> |
| ii) LG fault in 4–14, 50% distance from bus 14, $R_f = 200 \Omega$  | 14        | <b>4–14</b>     | <b>9.493</b>  |
|   |           | 14–15           | 2.929         |
|   |           | 14–13           | 1.079         |
| iii) LG fault in 16–19, 20% distance from bus 19, $R_f = 10 \Omega$ | 19        | <b>19–16</b>    | <b>1133</b>   |
|   |           | 19–20           | 139.5         |
| iv) LL fault in 24–23, 15% distance from bus 24, $R_f = 0.1 \Omega$ | 24        | <b>24–23</b>    | <b>4059</b>   |
|   |           | 24–26           | 3552          |

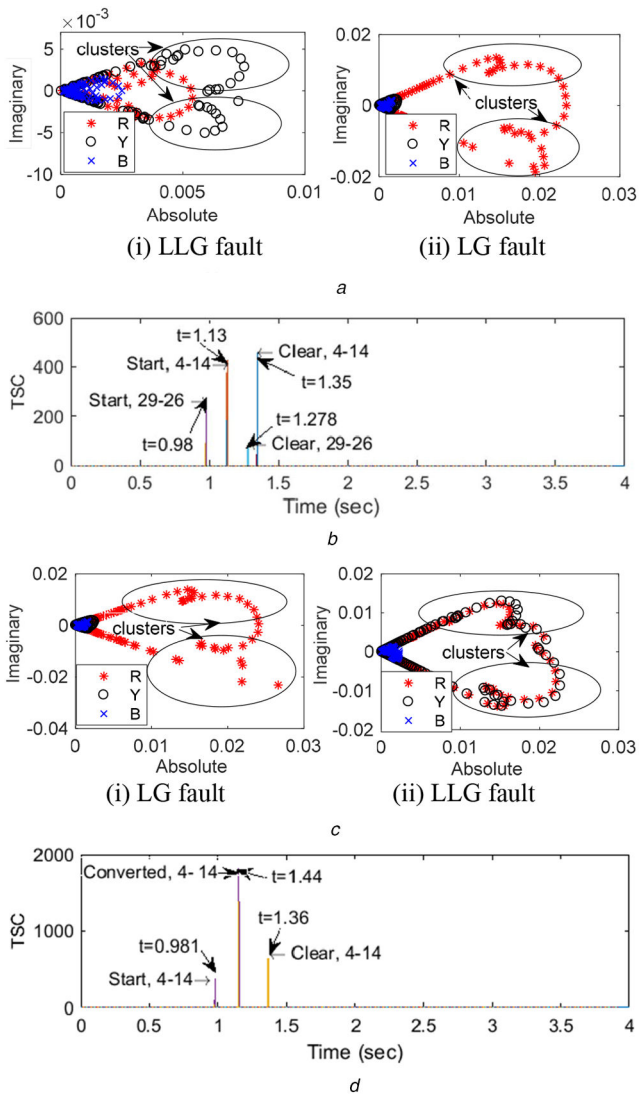
**Table 4** Fault detection on RTDS-based IEEE 39 bus system

| Case | First event |                 |            | Second event |                 |             |
|------|-------------|-----------------|------------|--------------|-----------------|-------------|
|      | Faulty bus  | Connected lines | TSC        | Faulty Bus   | Connected lines | TSC         |
| 1    | 29          | <b>29–26</b>    | <b>266</b> | 14           | 14–13           | 189         |
|      |             | 29–28           | 98         |              | 14–15           | 152         |
|      |             |                 |            |              | <b>14–4</b>     | <b>427</b>  |
| 2    | 14          | 14–13           | 199        | 14           | 14–13           | 890         |
|      |             | 14–15           | 139        |              | 14–15           | 678         |
|      |             | <b>14–4</b>     | <b>372</b> |              | <b>14–4</b>     | <b>1818</b> |

instant of subsequent events of fault occurrence on the line. The representation of scattered plots of absolute and imaginary components, calculated using HT was helpful in suggesting the fault types.

The proposed scheme was demonstrated on simulated signals for multiple fault events on standard bus systems with and without





**Fig. 11** Multiple fault event detection on real-time simulation

- (a) Fault types detection for case 1: (i) LLG fault, (ii) LG fault,  
 (b) Multiple faults sequence for case 1,  
 (c) Fault types detection for case 2: (i) LG fault, (ii) LLG fault,  
 (d) Multiple faults sequence for case 2

noise and as well as for real-time measurements. In other words, the sequence of LLG and LG faults, before the clearance of former events, on different lines were accurately detected and discriminated. Also, the sequence of LG fault converting into LLG fault, before the clearance of former event, on the same line was successfully detected in study. The novelty of the proposed approach lies in the fact that the proposed scheme was able to detect the fault location within 10 ms, and instead of analysing all the lines, only connected buses from the faulty bus were analysed for detection of the faulty line. It reduces the computational strain.

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